2SC5591

Silicon NPN triple diffusion mesa type

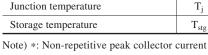
For horizontal deflection output

■ Features

- High breakdown voltage: 1700 V; supporting a large screen CRT and wider visible angle
- High-speed switching: Fall time $t_f < 0.2 \mu s$
- Low collector-emitter saturation voltage: Collector-emitter saturation voltage V_{CE(sat)} < 3 V
- Wide safe operation area

■ Absolute Maximum Ratings $T_C = 25$ °C

Parameter	Symbol	Rating	Unit	
Collector-base voltage (En	V _{CBO}	1700	V	
Collector-emitter voltage (E-B short)		V _{CES}	1 700	V
Collector-emitter voltage (Base open)		V _{CEO}	600	V
Emitter-base voltage (Collector open)		V_{EBO}	7	V
Base current		I_B	11	A
Collector current		I_{C}	20	A
Peak collector current *		I_{CP}	30	A
Collector power dissipation		P _C	70	W
	$T_a = 25$ °C		3.5	
Junction temperature		T _j	150	°C
Storage temperature		T_{stg}	-55 to +150	°C



Unit: mm 3.0±0.3 2: Collector 3: Emitter EIAJ: SC-94 TOP-3E-A1 Package

■ Electrical Characteristics $T_C = 25$ ° $C \pm 3$ °C

Parameter	Symbol	Conditions	Min	Тур	Max	Unit
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = 1000 \text{ V}, I_E = 0$			50	μΑ
		$V_{CB} = 1700 \text{ V}, I_E = 0$			1	mA
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = 7 \text{ V}, I_{C} = 0$			50	μΑ
Forward current transfer ratio	h _{FE}	$V_{CE} = 5 \text{ V}, I_{C} = 10 \text{ A}$	6		12	_
Collector-emitter saturation voltage	V _{CE(sat)}	$I_C = 10 \text{ A}, I_B = 2.5 \text{ A}$			3	V
Base-emitter saturation voltage	V _{BE(sat)}	$I_C = 10 \text{ A}, I_B = 2.5 \text{ A}$			1.5	V
Transition frequency	f_T	$V_{CE} = 10 \text{ V}, I_{C} = 0.1 \text{ A}, f = 0.5 \text{ MHz}$		3		MHz
Storage time	t _{stg}	I _C = 10 A, Resistance loaded			3.0	μs
Fall time	t _f	$I_{B1} = 2.5 \text{ A}, I_{B2} = -5.0 \text{ A}$			0.2	μs

Note) Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

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